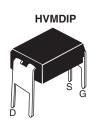
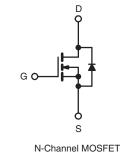




### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 3.0			
Q <sub>g</sub> (Max.) (nC)	24			
Q <sub>gs</sub> (nC)	3.3			
Q <sub>gd</sub> (nC)	13			
Configuration	Single			





#### FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1 inch pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION		
Package	HVMDIP	
Lead (Pb)-free	IRFD420PbF	
Lead (Fb)-free	SiHFD420-E3	
SnPb	IRFD420	
	SiHFD420	

ABSOLUTE MAXIMUM RATINGS (TA	= 25 °C, unless otherwis	se noted)			
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	500	v	
Gate-Source Voltage		V <sub>GS</sub>	± 20		
Continuous Drain Current	$V_{GS}$ at 10 V $T_A = 25 \degree C$	I <sub>D</sub>	0.37		
Continuous Drain Current	$T_A = 100 $ °C		0.23	А	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	3.0	1		
Linear Derating Factor		0.0083	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	51	mJ	
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	0.37	A	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	0.10	mJ	
Maximum Power Dissipation $T_A = 25 \text{ °C}$		PD	1.0	W	
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	00	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

- b.  $V_{DD}$  = 50 V, starting T<sub>J</sub> = 25 °C, L = 40 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 1.5 A.
- c.  $I_{SD} \leq 4.4$  A,  $dI/dt \leq 90$  A/µs,  $V_{DD} \leq V_{DS}, \, T_J \leq 150$  °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply



COMPLIANT

Vishay Siliconix



PARAMETER	SYMBOL	TYP		MAX.			UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		120	120		°C/W		
		•							
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 $^{\circ}$ C, u	nless otherw	ise noted)							
PARAMETER	SYMBOL	TES		ONS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 25	i0 μA	500	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I	<sub>D</sub> = 1 mA	-	0.59	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 25	50 µA	2.0	-	4.0	V	
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	,	-	-	± 100	nA	
Zaro Cata Voltago Drain Current	1	V <sub>DS</sub> =	= 500 V, V <sub>GS</sub>	= 0 V	-	-	25		
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 400 V	$V, V_{GS} = 0 V,$	T <sub>J</sub> = 125 °C	-	-	250	μA	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I <sub>D</sub> =	0.22 A <sup>b</sup>	-	-	3.0	Ω	
Forward Transconductance	<b>g</b> <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 1	.3 A <sup>b</sup>	1.5	-	-	S	
Dynamic									
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,		-	360	-		
Output Capacitance	Coss	$V_{DS} = 25 V$ ,			-	92	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz		-	37	-			
Total Gate Charge	Qg				-	-	24		
Gate-Source Charge	$Q_gs$	$V_{GS} = 10 \text{ V}$ $I_D = 2.1 \text{ A}, V_{DS} = 400 \text{ V}^{b}$		-	-	3.3	nC		
Gate-Drain Charge	Q <sub>gd</sub>				-	-	13		
Turn-On Delay Time	t <sub>d(on)</sub>				-	8.0	-		
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 2.1 A,		-	8.6	-	1		
Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 2.1 A,		33	-	ns			
Fall Time	t <sub>f</sub>				-	16	-	1	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-			
Internal Source Inductance	L <sub>S</sub>			-	6.0	-	nH		
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	ا <sub>S</sub>	MOSFET sym showing the			-	-	0.37		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	p - n junction diode		-	-	5.0	A		
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C,	, I <sub>S</sub> = 0.37 A,	V <sub>GS</sub> = 0 V <sup>b</sup>	-	-	1.6	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$- T_{J} = 25 \text{ °C, } I_{F} = 2.1 \text{ A, } dl/dt = 100 \text{ A/}\mu\text{s}^{\text{b}}$		-	260	520	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.70	1.4	μC		
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	Irn-on time is	negligible (turn	-on is dor	ninated b	$\frac{1}{100}$ y L <sub>S</sub> and	L <sub>D</sub> )	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.





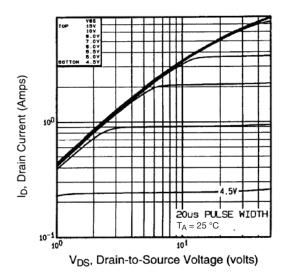


Fig. 1 - Typical Output Characteristics, T<sub>A</sub> = 25 °C

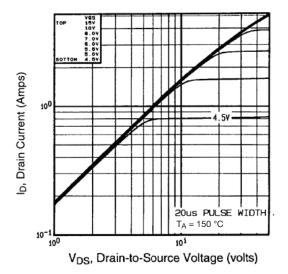
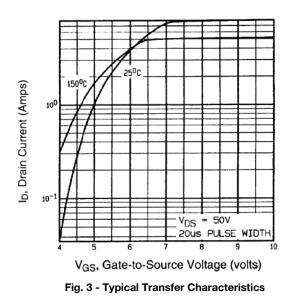


Fig. 2 - Typical Output Characteristics,  $T_A = 150 \ ^{\circ}C$ 



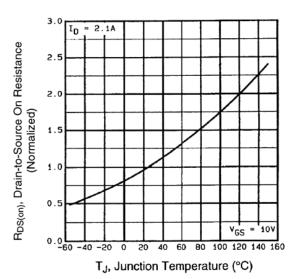


Fig. 4 - Normalized On-Resistance vs. Temperature



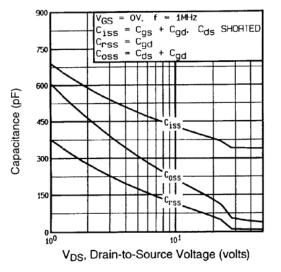


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

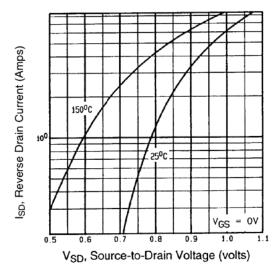


Fig. 7 - Typical Source-Drain Diode Forward Voltage

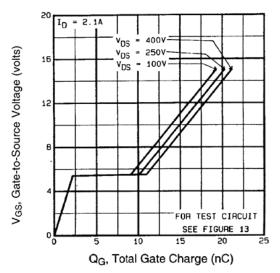
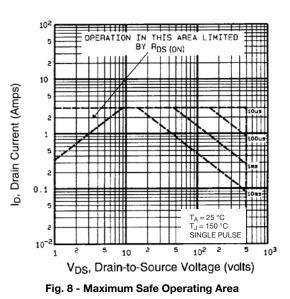


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





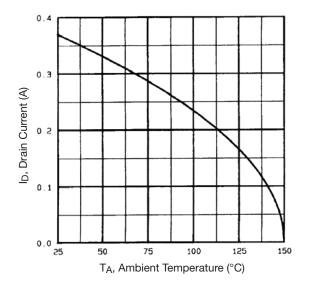


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

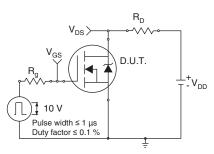


Fig. 10a - Switching Time Test Circuit

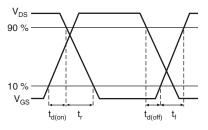


Fig. 10b - Switching Time Waveforms

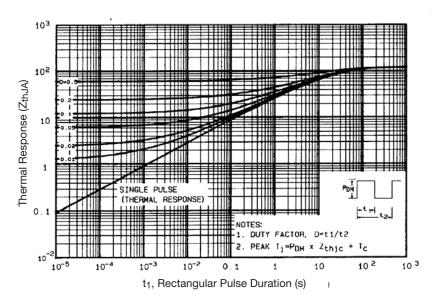


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



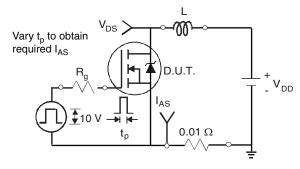


Fig. 12a - Unclamped Inductive Test Circuit

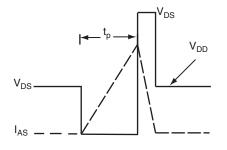


Fig. 12b - Unclamped Inductive Waveforms

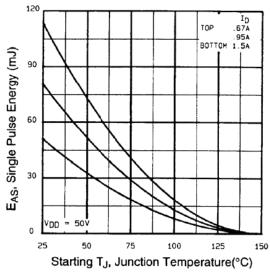
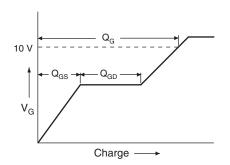


Fig. 12c - Maximum Avalanche Energy vs. Drain Current





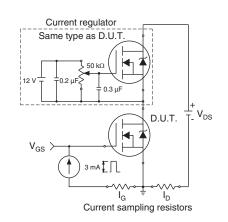
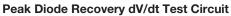
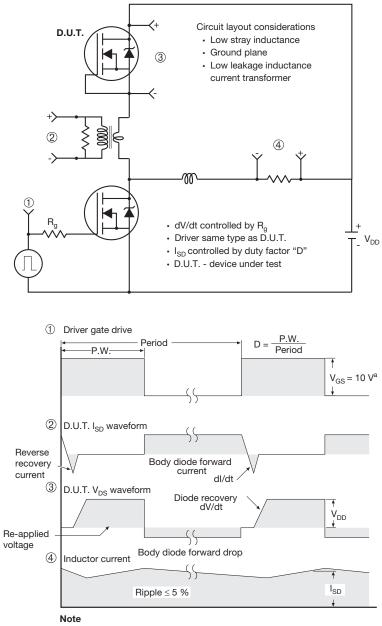


Fig. 13b - Gate Charge Test Circuit









a.  $V_{GS} = 5$  V for logic level devices

Fig. 14 - For N-Channel

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### HVM DIP (High voltage)





	INCHES		MILLIN	IETERS
DIM.	MIN.	MAX.	MIN.	MAX.
А	0.310	0.330	7.87	8.38
E	0.300	0.425	7.62	10.79
L	0.270	0.290	6.86	7.36
ECN: X10-0386-Rev. B, 0 DWG: 5974	06-Sep-10			

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.



Vishay

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